Se	arch	Notes	S

Application/Control No.	Applicant(s)/Patent under Reexamination
10/075,330	HORNG ET AL.
Examiner	Art Unit
Erin M. File	2634

SEARCHED				
Class	Subclass	Date	Examiner	
375	229	4/14/2005	EMF	
375	230	4/14/2005	EMF	
375	232	4/14/2005	EMF	
375	233	4/14/2005	EMF	
708	300	4/14/2005	EMF	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	4/14/2005	EMF
PALM INVENTORSHIP	4/14/2005	EMF
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